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Application Serial No. 10/811,768
Reply to office action of January 18, 2007

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The Claims

The listing of claims presented below will replace all prior versions, and listings, of claims in the application.

Listing of claims:

 (withdrawn) A method of manufacturing a semiconductor device substrate, said method comprising the steps of:

arranging on a base a temporary fixing member for temporarily fixing an electronic component;

temporarily fixing the electronic component on the base by using the temporary fixing member:

forming a substrate body on the base and the electronic component;
removing at least a portion of the base which portion corresponds to the
electronic component, thereby exposing the temporary fixing member; and
removing the temporary fixing member, thereby enabling the electronic
component to make an external connection.

- 2. (withdrawn) The method as claimed in claim 1, wherein the temporary fixing member is made of a metal.
- 3. (withdrawn) The method as claimed in claim 2, wherein the metal is a low-melting metal.
- 4. (withdrawn) The method as claimed in claim 1, wherein the temporary fixing member is a sheet member configured to be able to bond the electronic component to the base.
- 5. (withdrawn) The method as claimed in claim 4, wherein the sheet member is a

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thermo peeling tape.

- 6. (withdrawn) The method as claimed in claim 4, wherein the sheet member is a water-soluble sheet.
- 7. (withdrawn) The method as claimed in claim 4, wherein the sheet member is a UV tape.
- 8. (withdrawn) The method as claimed in claim 1, wherein the temporary fixing member is a liquid adhesive.
- 9. (withdrawn) The method as claimed in claim 1, wherein the step of removing at least the portion of the base removes the entire base.
- 10. (previously presented) A semiconductor device substrate, comprising: a substrate layer including an insulating layer and an interconnection layer, said insulating layer and said interconnection layer being stacked;

an electronic component buried in the insulating layer, a bump being formed on said electronic component acting as an electrode of the electronic component; and

a base layer that is in contact with the insulating layer of the substrate layer and having an opening formed at a portion corresponding to the electronic component to expose at least an end of the bump.

- 11. (previously presented) The semiconductor device substrate as claimed in claim 10, wherein the bump projects through said substrate layer so as to be connectable to an externally provided semiconductor element.
- 12. (previously presented) The semiconductor device substrate as claimed in claim 10, wherein the bump projects from a surface of said electronic component facing the opening so as to be connectable to an externally provided semiconductor element.

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- 13. (previously presented) The semiconductor device substrate as claimed in claim 10, wherein the substrate layer has a depressed portion between the opening and the electronic component to expose the bump.
- 14. (withdrawn) A semiconductor device, comprising:
 - a semiconductor device substrate including:
- a substrate layer including an insulating layer and an interconnection layer, said insulating layer and said interconnection layer being stacked;

an electronic component buried in the insulating layer, a bump being formed on said electronic component acting as an electrode of the electronic component; and

a base layer that is in contact with the insulating layer of the substrate layer and having an opening formed at a portion corresponding to the electronic component to expose at least an end of the bump; and

a semiconductor element mounted on said semiconductor device substrate and electrically connected to the bump of said electronic component.

- 15. (withdrawn) The semiconductor device as claimed in claim 14, wherein the bump of said electronic component projects through said substrate layer.
- 16. (withdrawn) The semiconductor device as claimed in claim 14, wherein the bump of said electronic component projects from a surface of said electronic component that faces the opening.
- 17. (withdrawn) The semiconductor device as claimed in claim 14, wherein the substrate layer has a depressed portion between the opening and the electronic component.
- 18. (withdrawn) A semiconductor device substrate, comprising:

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a substrate layer including an insulating layer and an interconnection layer, said insulating layer and said interconnection layer being stacked;

an electronic component buried in the insulating layer, a bump being formed on said electronic component acting as an electrode of the electronic component; and

a base layer that is in contact with the insulating layer of the substrate layer and having an opening formed at a portion corresponding to the electronic component to expose at least an end of the bump,

wherein the substrate layer has a depressed portion between the opening and the electronic component to expose the bump.

- 19. (withdrawn) The semiconductor device substrate as claimed in claim 18, wherein the bump projects into the depressed portion.
- 20. (withdrawn) The semiconductor device substrate as claimed in claim 18, wherein a top of the bump is substantially uniform with a surface of the substrate layer that faces the opening of the base layer.
- 21. (withdrawn) A semiconductor device, comprising:
 - a semiconductor device substrate including:
- a substrate layer including an insulating layer and an interconnection layer, said insulating layer and said interconnection layer being stacked;

an electronic component buried in the insulating layer, a bump being formed on said electronic component acting as an electrode of the electronic component; and

a base layer that is in contact with the insulating layer of the substrate layer and having an opening formed at a portion corresponding to the electronic component to expose at least an end of the bump,

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wherein the substrate layer has a depressed portion between the opening and the electronic component to expose the bump; and

a semiconductor element mounted on said semiconductor device substrate and electrically connected to the bump of said electronic component.

- 22. (withdrawn) The semiconductor device as claimed in claim 21, wherein the bump projects into the depressed portion.
- 23. (withdrawn) The semiconductor device as claimed in claim 21, wherein a conductive member is provided between the bump and an electrode of the semiconductor element.